ZXM62N03E6

30V N-CHANNEL ENHANCEMENT MODE MOSFET

SUMMARY

 $V_{(BR)DSS}=30V; R_{DS(ON)}=0.11\Omega; I_{D}=3.2A$

DESCRIPTION

This new generation of high density MOSFETs from Zetex utilise a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

FEATURES

- Low on-resistance
- Fast switching speed
- Low threshold
- Low gate drive
- SOT23-6 package

APPLICATIONS

- DC DC converters
- Power management functions
- Disconnect switches
- Motor control

ORDERING INFORMATION

DEVICE	REEL SIZE (inches)	TAPE WIDTH (mm)	QUANTITY PER REEL
ZXM62N03E6TA	KM62N03E6TA 7		3000 units
ZXM62N03E6TC	13	8mm embossed	10000 units

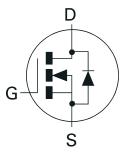
DEVICE MARKING

ISSUE 1 - JUNE 2004

• 2N03









Top View



ZXM62N03E6

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V _{DSS}	30	V
Gate Source Voltage	V _{GS}	±20	V
Continuous Drain Current (V_{GS} =10V; T_A =25°C)(b) (V_{GS} =10V; T_A =70°C)(b)	I _D	3.2 2.6	А
Pulsed Drain Current (c)	I _{DM}	18	А
Continuous Source Current (Body Diode) (b)	Is	2.1	А
Pulsed Source Current (Body Diode)	I _{SM}	18	А
Power Dissipation at T _A =25°C (a) Linear Derating Factor	P _D	1.1 8.8	W mW/°C
Power Dissipation at T _A =25°C (b) Linear Derating Factor	P _D	1.7 13.6	W mW/°C
Operating and Storage Temperature Range	T _j :T _{stg}	-55 to +150	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)	R _{eja}	113	°C/W
Junction to Ambient (b)	R _{θJA}	73	°C/W

NOTES:

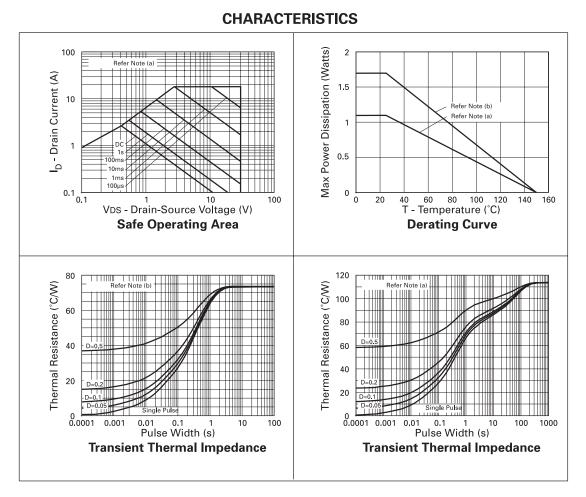
(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions

(b) For a device surface mounted on FR4 PCB measured at t ${\leqslant}5$ secs.

(c) Repetitive rating - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.



ZXM62N03E



ISSUE 1 - JUNE 2004



ZXM62N03E6

ELECTRICAL CHARACTERISTICS (at Tamb = 25°C unless otherwise stated)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.	
STATIC		1			-		
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	$I_{D}=250\mu A, V_{GS}=0V$	
Zero Gate Voltage Drain Current	I _{DSS}			1	μA	V _{DS} =30V, V _{GS} =0V	
Gate-Body Leakage	I _{GSS}			100	nA	$V_{GS} = (20V, V_{DS} = 0V)$	
Gate-Source Threshold Voltage	V _{GS(th)}	1.0			V	I_{D} =250 μ A, V_{DS} = V_{GS}	
Static Drain-Source On-State Resistance (1)	R _{DS(on)}			0.11 0.15	Ω Ω	V_{GS} =10V, I_{D} =2.2A V_{GS} =4.5V, I_{D} =1.1A	
Forward Transconductance	9 _{fs}	1.1			S	V _{DS} =10V,I _D =1.1A	
DYNAMIC (3)							
Input Capacitance	C _{iss}		380		pF	V _{DS} =25 V, V _{GS} =0V, f=1MHz	
Output Capacitance	C _{oss}		90		pF		
Reverse Transfer Capacitance	C _{rss}		30		pF	1	
SWITCHING(2) (3)							
Turn-On Delay Time	t _{d(on)}		2.9		ns	V _{DD} =15V, I _D =2.2A	
Rise Time	t _r		5.6		ns		
Turn-Off Delay Time	t _{d(off)}		11.7		ns	$R_{G} = 6.0\Omega, R_{D} = 6.7\Omega$ (refer to test	
Fall Time	t _f		6.4		ns	circuit)	
Total Gate Charge	Qg			9.6	nC	-V _{DS} =24V,V _{GS} =10V, I _D =2.2A (refer to	
Gate-Source Charge	Q _{gs}			1.7	nC		
Gate Drain Charge	Q _{gd}			2.8	nC	test circuit)	
SOURCE-DRAIN DIODE							
Diode Forward Voltage (1)	V _{SD}			0.95	V	$T_{j}=25^{\circ}C, I_{S}=2.2A, V_{GS}=0V$	
Reverse Recovery Time (3)	t _{rr}		18.8		ns	T _j =25°C, I _F =2.2A, di/dt= 100A/μs	
Reverse Recovery Charge (3)	Q _{rr}		11.4		nC		

(1) Measured under pulsed conditions. Width=300 $\mu s.$ Duty cycle @2% .

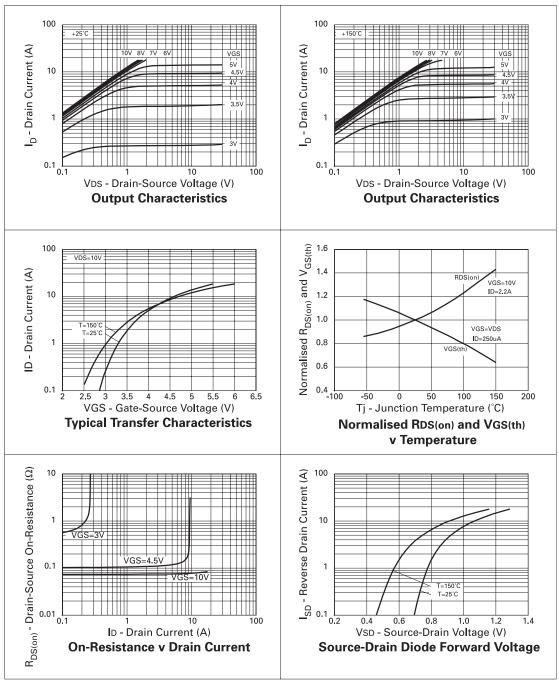
(2) Switching characteristics are independent of operating junction temperature.

(3) For design aid only, not subject to production testing.



ZXM62N03E6

TYPICAL CHARACTERISTICS

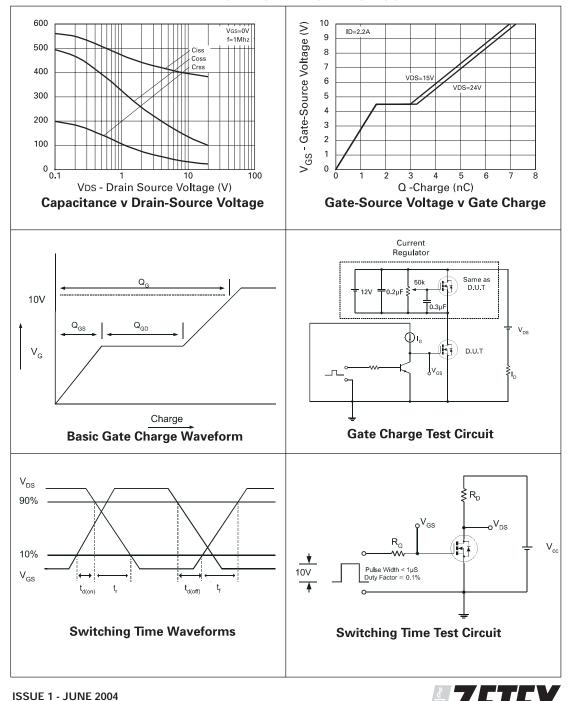


ISSUE 1 - JUNE 2004



ZXM62N03E6

TYPICAL CHARACTERISTICS



ONDUCTORS

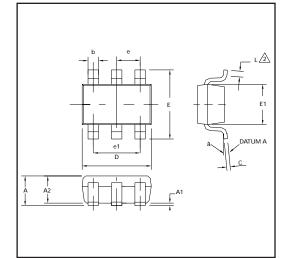
ZXM62N03E6

ISSUE 1 - JUNE 2004



ZXM62N03E6

PACKAGE DIMENSIONS



DIM	Millimeters		Inches		
	Min	Max	Min	Max	
А	0.90	1.45	0.35	0.057	
A1	0.00	0.15	0	0.006	
A2	0.90	1.30	0.035	0.051	
b	0.35	0.50	0.014	0.019	
С	0.09	0.20	0.0035	0.008	
D	2.80	3.00	0.110	0.118	
E	2.60	3.00	0.102	0.118	
E1	1.50	1.75	0.059	0.069	

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ISSUE 1 - JUNE 2004

PAD LAYOUT DETAILS

